

<b>Notice of References Cited</b>	Application/Control No. 10/735,844		Applicant(s)/Patent Under Reexamination TAKEHARA ET AL.	
	Examiner Alvin T. Raetzsch		Art Unit 1754	Page 1 of 1

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*	A	US-2004/0057896 A1	03-2004	Kronholm et al.	423/461
*	B	US-5,458,742	10-1995	Mueller et al.	203/91
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